

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10200-005001	Application No. 10/082,403
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant David J. Luneau	
		Filing Date February 25, 2002	Group Art Unit 2643

### U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

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### Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

### Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
BWT	AQ	Garland et al., "Application Notes, Proactive Loop Maintenance via Intelligent Pathway Application Example: Customer Premise Loop Test Interface Capability", Lucent Technologies, Inc., Issue 0.3, November 24, 1998
BWT	AR	Press Release, "Turnstone's New T100 TDR Card Enables Remote, Long-Reach TDR Testing Without Truck Rolls", Source: Turnstone Systems, Inc., June 5, 2001
BWT	AS	Dunford et al., Consultronics, "xDSL Service Testing A White Paper for Telecommunication and Internet Service Providers"
BWT	AT	Turnstone, "Accelerate Residential DSL Deployment: Loop Management throughout the DSL Lifecycle, White Paper"

Examiner Signature

*Baryuda*

Date Considered

3/1/04

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.